DELIVERY SPECIFICATION

SPEC. No. C-150C-g
D A T E : Feb., 2022

Τo

Non-Controlled Copy

CUSTOMER'S PRODUCT NAME

Multilayer Ceramic Chip Capacitors

(Guaranteed at High Temperature)

Bulk and tape packaging 【RoHS compliant】

C1005,C1608,C2012,C3216,C3225,C4532,C5750 Type

NP0,X8R,X8L Characteristics

Please return this specification to TDK representatives with your signature. If orders are placed without returned specification, please allow us to judge that specification is accepted by your side.

RECEIPT CONFIRMATION

DATE: YEAR MONTH DAY

TDK Corporation Sales Electronic Components Sales & Marketing Group

Engineering

Electronic Components Business Company Ceramic Capacitors Business Group

APPROVED	Person in charge

APPROVED	CHECKED	Person in charge

SCOPE

This delivery specification shall be applied to chip type multilayer ceramic capacitors to be delivered to

PRODUCTION PLACES

Production places defined in this specification shall be TDK Corporation, TDK(Suzhou)Co.,Ltd and TDK Components U.S.A.,Inc.

PRODUCT NAME

The name of the product to be defined in this specifications shall be $\underline{C} \Diamond \Diamond \Diamond \Diamond \Diamond \Diamond \Diamond \Diamond \triangle \Box \Box \Box \times$.

REFERENCE STANDARD

JIS C 5101-1:2010	Fixed capacitors for use in electronic equipment-Part 1: Generic specification
C 5101-21:2014	Fixed capacitors for use in electronic equipment-Part 21: Sectional specification
	: Fixed surface mount multilayer capacitors of ceramic dielectric, Class1
C 5101-22:2014	Fixed capacitors for use in electronic equipment-Part 22 : Sectional specification
	: Fixed surface mount multilayer capacitors of ceramic dielectric, Class2
C 0806-3:2014	Packaging of components for automatic handling - Part 3: Packaging of
	surface mount components on continuous tapes
JEITA RCR-2335 C 2014	Safety application guide for fixed ceramic capacitors for use in electronic
	equipment

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<EXPLANATORY NOTE>

When the mistrust in the spec arises, this specification is given priority. And it will be confirmed by written spec change after conference of both posts involved.

This specification warrants the quality of the ceramic chip capacitor. Capacitors should be evaluated or confirmed a state of mounted on your product.

If the use of the capacitors goes beyond the bounds of this specification, we can not afford to guarantee.

Division	Date	SPEC. No.
Ceramic Capacitors Business Group	February, 2022	C-150C-g

1. CODE CONSTRUCTION

(Example) <u>C1005</u> <u>X8R</u> <u>1E</u> <u>103</u> <u>K</u> <u>T</u> <u>OOOO</u> (1) (2) (3) (4) (5) (6) (7)

Ceramic dielectric

Terminal electrode

Terminal electrode

Internal electrode

Case size	Dimensions (Unit : mm)						
[EIA style]	L	W T		В	G		
C1005	1.00±0.05	1.00±0.05		0.10 min.	0.00		
[CC0402]	1.00±0.10	0.50±0.10	0.50±0.10	U. IU IIIII.	0.30 min.		
	1.60±0.10	0.80±0.10	0.80±0.10				
C1608 [CC0603]	1.60±0.15	0.80±0.15	0.80±0.15	0.20 min.	0.30 min.		
	1.60±0.20	0.80±0.20	0.80±0.20				
			0.60±0.15				
C2012	2.00±0.20	1.25±0.20	0.85±0.15		0.50 min.		
[CC0805]			1.25±0.20	0.20 min.			
	2.00 +0.25 - 0.15	1.25 ^{+0.25} - 0.15	1.25 ^{+0.25} - 0.15				
	3.20±0.20	1.60±0.20	0.60±0.15	0.20 min.	1.00 min.		
			0.85±0.15				
C3216 [CC1206]			1.15±0.15				
[CC1200]			1.60±0.20				
	3.20 ^{+0.30} _{-0.10} 1.60 ^{+0.30} _{-0.10}		1.60 ^{+0.30} - 0.10				
			1.25±0.20				
00007			1.60±0.20				
C3225 [CC1210]	3.20±0.40	2.50±0.30	2.00±0.20	0.20 min.			
[00.2.0]			2.30±0.20				
			2.50±0.30				
			2.00±0.20				
C4532 [CC1812]	4.50±0.40	3.20±0.40	2.30±0.20	0.20 min.			
			3.20±0.30				
C5750	5.70±0.40	5.00±0.40	2.30±0.20	0.20 min.			
[CC2220]	5.70±0.40	5.00±0.40	2.80±0.30	0.20 111111.			

^{*} As for each item, please refer to detail page on TDK web.

(2) Temperature Characteristics

* Details are shown in table 1 No.6 and No.7 at 7.PERFORMANCE

(3) Rated Voltage

Symbol	Rated Voltage	Symbol	Rated Voltage
2 J	DC 630 V	1 E	DC 25 V
2 W	DC 450 V	1 C	DC 16 V
2 E	DC 250 V	1 A	DC 10 V
2 A	DC 100 V	0 J	DC 6.3 V
1 H	DC 50 V	0 G	DC 4V

(4) Rated Capacitance

Stated in three digits and in units of pico farads (pF). The first and Second digits identify the first and second significant figures of the capacitance, the third digit identifies the multiplier.

(Example)	
Symbol	Rated Capacitance
103	10,000 pF

(5) Capacitance tolerance

Symbol	Tolerance	Capacitance	
С	± 0.25 pF	10pE and under	
D	± 0.5 pF	10pF and under	
J	± 5%		
K	± 10 %	Over 10pF	
М	± 20 %		

(6) Packaging

* C1005 type is applicable to tape packaging only.

Symbol	Packaging
В	Bulk
Т	Taping

(7) TDK internal code

2. COMBINATION OF RATED CAPACITANCE AND TOLERANCE

Class	Temperature Characteristics	Capacitanc	e tolerance	Rated capacitance
		10pE and under	C (± 0.25pF)	1, 2, 3, 4, 5
1	1 NP0	10pF and under	D (± 0.5pF)	6, 7, 8, 9, 10
		Over 10pF	J (± 5%)	E – 6 series E – 12 series
2	X8R X8L	K (± 10 %)	M (± 20 %)	E – 6 series

Capacitance Step in E series

E series		Capacitance Step										
E- 6	1.	1.0 1.5 2.2 3.3 4.7 6.8										
E-12	1.0	1.2	1.5	1.8	2.2	2.7	3.3	3.9	4.7	5.6	6.8	8.2

3. OPERATING TEMPERATURE RANGE

Min. operating	Max. operating	Reference
Temperature	Temperature	Temperature
-55°C	150°C	25°C

4. STORING CONDITION AND TERM

Storing temperature	Storing humidity	Storing term
5~40°C	20~70%RH	Within 6 months upon receipt.

5. P.C. BOARD

When mounting on an aluminum substrate, the capacitors are more likely to be affected by heat stress from the substrate.

Please inquire separate specification when mounted on the substrate.

6. INDUSTRIAL WASTE DISPOSAL

Dispose this product as industrial waste in accordance with the Industrial Waste Law.

7. PERFORMANCE

table 1

No.	Item	Performance	Test or inspection method			nethod	
1	External Appearance	No defects which may affect performance.	Inspect with magnifying glass (3x)			s (3x)	
2	Insulation Resistance	10,000MΩ or 500MΩ·μF min. (As for the capacitors of rated voltage 16V DC and lower, $100MΩ·μF$ min.)	Measuring voltage: Rated voltage (As for the capacitor of rated voltage 630V DC, apply 500V DC.) Voltage application time: 60s.			ed voltage	
3	Voltage Proof	Withstand test voltage without insulation breakdown or other damage.	Class	Class Rate voltage			Apply voltage
		uamage.			≦100V		× rated voltage
			1		RV≦500V		5 × rated voltage
					0V <rv 1.3="" rated="" td="" voltag<="" ×=""><td></td></rv>		
			2 RV≦100V 2.5 x rated voltage Voltage application time : 1s. Charge / discharge current : 50mA or lower				
4	Capacitance	Within the specified tolerance.	《Class	1》			
			Capac	itance	Measurin frequenc		Measuring voltage
				oF and der	1MHz±10	%	0.5 ~ 5 Vrms.
			Over 1	000pF	1kHz±10	%	
			《Class	2》			
			Capac		Measurin frequenc		Measuring voltage
			10uF und	and der	1kHz±10	%	1.0±0.2Vrms
			Over	10uF	120Hz±20	%	0.5±0.2Vrms.
5	Q (Class1)	Please refer to detail page on TDK web.	See No.		s table for	mea	asuring
	Dissipation Factor (Class2)						

(contin	ued)		T		1		
No.	I	ltem		Performance	Test	or inspection method	
6	Temperate Character of Capaci (Class1)	ristics	T.C. NP0 Capacita drift	Temperature Coefficient (ppm/°C) 0 ± 30 ance Within ± 0.2% or ± 0.05pF, whichever larger.	calculated to 85°C temper Measuring	re coefficient shall be based on values at 25°C and erature. temperature below 25°C 0°C and -25°C.	
7	7 Temperature Characteristics of Capacitance (Class2)		Capacitance Change (%) No voltage applied X8R: ±15		Capacitance shall be measured by the steps shown in the following table after thermal equilibrium is obtained for each step. ΔC be calculated ref. STEP3 reading		
				X8L: +15	Step	Temperature(°C)	
				- 40	1	25 ± 2	
					2	-55 ± 2	
					3	25 ± 2	
					4	150 ± 2	
					As for measuring voltage, please contact with our sales representative.		
8	8 Robustness of Terminations		_	ermination coming off, f ceramic, or other igns.	P.C.Board s Apply a pus center of a direction of Pushing for (2N is appli Holding tim	rce : 5N led for C1005 type.) le : 10±1s Pushing force P.C. Board	
9	Bending	External appearance	No mechan	ical damage.	Reflow solo	50 F R230	

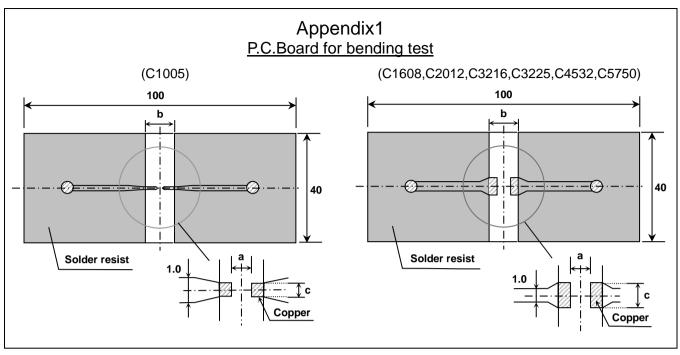
No.	Item			Perf	ormance	Test o	r inspection method
10	Solderability		terminatio 25% may spots but spot. Ceramic s not be exp	n. have p not cor surface posed c	ver over 75% of in holes or rough incentrated in one of A sections shall due to melting or ation material. A section	Solder: Flux: Solder temp.: Dwell time: Solder position:	Sn-3.0Ag-0.5Cu Isopropyl alcohol (JIS K 8839) Rosin (JIS K 5902) 25% solid solution. 245±5°C 3±0.3s. Until both terminations are completely soaked.
11	to solder heat	External appearance Capacitance	termination	ons sha	llowed and all be covered at new solder. Change from the value before test	Solder: Flux: Solder temp.:	Sn-3.0Ag-0.5Cu Isopropyl alcohol (JIS K 8839) Rosin (JIS K 5902) 25% solid solution. 260±5°C 10±1s.
			Class1	NP0 X8R X8L	Capacitance drift within ±2.5% or ±0.25pF, whichever larger. ±7.5 %	Solder position : Pre-heating :	Until both terminations are completely soaked. Temp. — 110~140°C
		Q (Class1) D.F. (Class2) Insulation Resistance Voltage proof	Meet the Meet the Meet the No insula damage.	initial s	pec.	Leave the cap condition for Class 1 : 6~24	Time — 30∼60s. pacitors in ambient

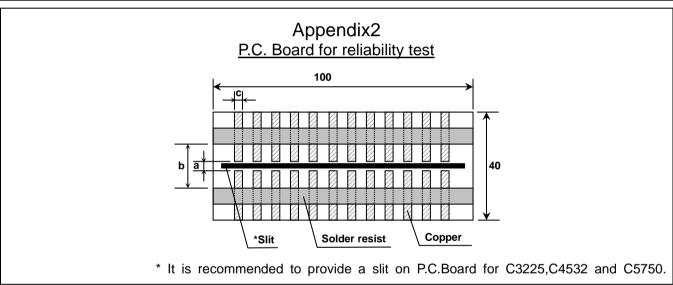
No.	Ite	Item		Per	formance	7	Test or inspection r	method		
12	Vibration	External appearance	No mech	anical	damage.	-	Frequency: 10~55~10Hz Reciprocating sweep time: 1 min. Amplitude: 1.5mm Repeat this for 2h each in 3 perpendicular directions(Total 6h). Reflow solder the capacitors on a P.C.Board shown in Appendix2 before testing.			
		Q (Class1) D.F.	Charact Class1 Class2 Meet the	X8R X8L initial s	•	Amplitu Repeat perpend Reflow P.C.Box				
13	Temperature	(Class2) External	No mech				Expose the capacitors in the condit			
	cycle	appearance					step1 through step 4 listed in the following table.			
		Capacitance	Charact	teristics	Change from the	Temp.	Temp. cycle : 5 cycles			
				T	O Please contact	Step	Temperature(°C)	Time (min.)		
			Class1	NP0		1	-55 ± 3	30 ± 3		
			I VOD I	representative.	2	Ambient Temp.	2 ~ 5			
		Q	Meet the	initial	Spec	3	150 ± 2	30 ± 2		
		(Class1)	Wicci tric	miliar	эрсс.	4	Ambient Temp.	2 ~ 5		
		D.F. (Class2)	Meet the	initial	spec.	condition	the capacitors in a on for the capacitors in a capacitors in a capacitors.	mbient		
		Insulation Resistance	Meet the	initial	spec.	Class 2	2: 24±2h before m			
		Voltage proof				P.C.Board shown in Appendix2 before				

No.	Item		Perfo	rmance	Test or inspection method		
14	Moisture Resistance	External appearance	No mechanical da		Test temp.: 40±2°C Test humidity: 90~95%RH		
	(Steady State)	Capacitance	Characteristics Class1 NP0 Class2 X8R X8L	Change from the value before test Please contact with our sales representative.	Test time: 500 +24,0h Leave the capacitors in ambient condition for Class 1: 6~24h Class 2: 24±2h before measurement.		
		Q (Class1)	Capacitance 30pF and over 10pF and over under 30pF Under 10pF C: Rated capa	275+5/2×C min. 200+10×C min.	Reflow solder the capacitors on a P.C.Board shown in Appendix2 before testing.		
		D.F. (Class2) Insulation Resistance		Ω·μF min.			
15	Moisture Resistance	External appearance	No mechanical da		Test temp.: 40±2°C Test humidity: 90~95%RH Applied voltage: Rated voltage		
		Capacitance	Characteristics Class1 NP0 Class2 X8R X8L	Change from the value before test Please contact with our sales representative.	Test time: 500 +24,0h Charge/discharge current: 50mA or lower Leave the capacitors in ambient condition for Class 1: 6~24h Class 2: 24±2h before measurement.		
		Q (Class1) D.F. (Class2) Insulation Resistance	smaller. (As for the capaci	100+10/3×C min. citance (pF)	Reflow solder the capacitors on a P.C.Board shown in Appendix2 before testing. Initial value setting (only for class 2) Voltage conditioning 《After voltage treat the capacitors under testing temperature and voltage for 1 hour,》 leave the capacitors in ambient condition for 24±2h before measurement. Use this measurement for initial value.		

No.				Perfo	rmance	Test or inspection method
16	Life	External appearance	No mecha	No mechanical damage.		Test temp.: 150±2°C Applied voltage: Please contact with our sales representative.
		Capacitance	Characte	eristics	Change from the value before test	Test time: 1,000 +48,0h Charge/discharge current: 50mA or lower
			Class1	NP0	Please contact	Leave the capacitors in ambient
			Class2	X8R X8L	with our sales representative.	condition for Class 1 : 6~24h
					_	Class 2 : 24±2h before measurement.
		Q				Reflow solder the capacitors on a
		(Class1)	Capacitance		Q	P.C.Board shown in Appendix2 before
			30pF ar	nd over	350 min.	testing.
			10pF ar under		275+5/2×C min.	Initial value setting (only for class 2)
			Under	10pF	200+10×C min.	Voltage conditioning 《After voltage
			C : Rated capacitance (pF)		citance (pF)	treat the capacitors under testing temperature and voltage for 1 hour,
	D.F.		200% of in	itial spe	ec. max.	leave the capacitors in ambient
		(Class2)				condition for 24±2h before measurement.
		Insulation			Ω·μF min.	Use this measurement for initial value.
		Resistance	whicheve	r smalle	er.	
			(As for the	capaci	itors of rated voltage	
			16V DC a	nd lowe	er, 10MΩ·μF min.)	

^{*}As for the initial measurement of capacitors (Class2) on number 7,11,12,13 and 14, leave capacitors at 150 0,-10 $^{\circ}$ C for 1 hour and measure the value after leaving capacitors for 24 ± 2h in ambient condition.





			(Unit : mm)
Symbol Case size	а	b	С
C1005 [CC0402]	0.4	1.5	0.5
C1608 [CC0603]	1.0	3.0	1.2
C2012 [CC0805]	1.2	4.0	1.65
C3216 [CC1206]	2.2	5.0	2.0
C3225 [CC1210]	2.2	5.0	2.9
C4532 [CC1812]	3.5	7.0	3.7
C5750 [CC2220]	4.5	8.0	5.6

1. Material : Glass Epoxy(As per JIS C6484 GE4)

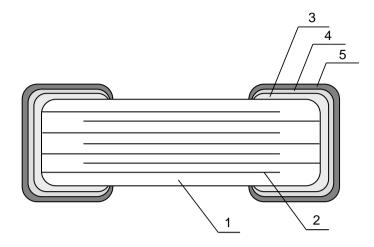
2. Thickness: Appendix 1 — 0.8mm (C1005)

- 1.6mm (C1608,C2012,C3216,C3225,C4532,C5750)

: Appendix 2 — 1.6mm

Copper(Thickness:0.035mm)
Solder resist

8. INSIDE STRUCTURE AND MATERIAL



Na	NAME	MATERIAL				
No.	NAME	Class1	Class2			
1	Dielectric	CaZrO₃	BaTiO₃			
2	Electrode	Nickel (Ni)				
3		Coppe	r (Cu)			
4	Termination	Nickel (Ni)				
5		Tin (Sn)				

9. PACKAGING

Packaging shall be done to protect the components from the damage during transportation and storing, and a label which has the following information shall be attached.

- 9.1 Each plastic bag for bulk packaging contains 1000pcs. And the minimum quantity for Bulk packaging is 1000pcs.
- 9.2 Tape packaging is as per 13. TAPE PACKAGING SPECIFICATION.
 - *C1005[CC0402] type is applicable to tape packaging only.
 - 1) Inspection No.*
 - 2) TDK P/N
 - 3) Customer's P/N
 - 4) Quantity

*Composition of Inspection No.

Example
$$\underline{F} \ \underline{2} \ \underline{A} \ - \ \underline{23} \ - \ \underline{001}$$
 (a) (b) (c) (d) (e)

- (a) Line code
- (b) Last digit of the year
- (c) Month and A for January and B for February and so on. (Skip I)
- (d) Inspection Date of the month.
- (e) Serial No. of the day

*Composition of new Inspection No.

(Implemented on and after May 1, 2019 in sequence)

- (a) Prefix
- (b) Line code
- (c) Last digit of the year
- (d) Month and A for January and B for February and so on. (Skip I)
- (e) Inspection Date of the month.
- (f) Serial No. of the day(00 ~ ZZ)
- (g) Suffix($00 \sim ZZ$)

10. RECOMMENDATION

As for C3225[CC1210] and larger, It is recommended to provide a slit (about 1mm width) in the board under the components to improve washing Flux. And please make sure to dry detergent up completely before.

11. SOLDERING CONDITION

As for C1005[CC0402], C3225[CC1210] and larger, reflow soldering only. For other case sizes than the above, reflow soldering is recommended.

^{*} It was shifted to the new inspection No. on and after May 2019, but the implementation timing may be different depending on shipment bases. Until the shift is completed, either current or new composition of inspection No. will be applied.

12. CAUTION

No.	Process	Condition
1	Operating Condition (Storage, Use,	1-1. Storage, Use The capacitors must be stored in an ambient temperature of 5 to 40°C with a relative humidity of 20 to 70%RH. JIS C 60721-3-1 Class 1K2 should be followed for the other climatic conditions.
	Transportation)	1) High temperature and humidity environment may affect a capacitor's solder ability because it accelerates terminal oxidization. They also deteriorate performance of taping and packaging. Therefore, SMD capacitors shall be used within 6 months. For capacitors with terminal electrodes consisting of silver or silver-palladium which tend to become oxidized or sulfurized, use as soon as possible, such as within one month after opening the bag.
		2) When capacitors are stored for a longer time period than 6 months, confirm the solderability of the capacitors prior to use. During storage, keep the minimum packaging unit in its original packaging without opening it. Do not deviate from the above temperature and humidity conditions even for a short term.
		3) Corrosive gasses in the air or atmosphere may result in deterioration of the reliability, such as poor solderability of the terminal electrodes. Do not store capacitors where they will be exposed to corrosive gas (e.g., hydrogen sulfide, sulfur dioxide, chlorine ammonia etc.)
		4) Solderability and electrical performance may deteriorate due to photochemical change in the terminal electrode if stored in direct sunlight, or due to condensation from rapid changes in humidity. The capacitors especially which use resin material must be operated and stored in an environment free of dew condensation, as moisture absorption due to condensation may affect the performance.
		5) Refer to JIS C 60721-3-1, class 1K2 for other climate conditions.
		1-2. Handling in transportation In case of the transportation of the capacitors, the performance of the capacitors may be deteriorated depending on the transportation condition. (Refer to JEITA RCR-2335C 9.2 Handling in transportation)
2	Circuit design	2-1. Operating temperature
	<u></u> Caution	Upper category temperature (maximum operating temperature) is specified. It is necessary to select a capacitor whose rated temperature us higher than the operating temperature. Also, it is necessary to consider the temperature distribution in the equipment and seasonal temperature variation.
		2) Surface temperature including self heating should be below maximum operating
		temperature. Due to dielectric loss, capacitors will heat itself when AC is applied due to ESR. Especially at high frequencies, please be careful that the heat might be so extreme.
		Also, even if the surface temperature of the capacitor includes self-heating and is the maximum operating temperature or lower, excessive heating of the capacitor due to self-heating may cause deterioration of the characteristics and reliability of the capacitor.
		The self-heating temperature rise of the capacitor changes depending on the difference in heat radiation due to the mounting method to the device, the ambient temperature, the cooling method of the device and circuit board material and the design, etc.
		The load should be contained so that the self-heating temperature rise of the capacitor body in a natural convection environment at an ambient temperature of 25°C remain below 20°C.
		When using in a high-frequency circuit or a circuit in which a capacitor generates heat, such as when a high-frequency ripple current flows, pay attention to the above precautions. (Note that accurate measurement may not be possible with self-heating measurement when the equipment applies cooling other than natural convection such as a cooling fan.)
		The electrical characteristics of the capacitors will vary depending on the temperature. The capacitors should be selected and designed in taking the temperature into consideration.

No.	Process	Condition				
2	Circuit design Caution	 2-2. When overvoltage is applied Applying overvoltage to a capacitor may cause dielectric breakdown and result in a short circuit. The duration until dielectric breakdown depends on the applied voltage and the ambient temperature. 2-3. Operating voltage 1) Operating voltage across the terminals should be below the rated voltage. When AC and DC are super imposed, V0-P must be below the rated voltage. — (1) and (2) AC or pulse with overshooting, VP-P must be below the rated voltage. — (3), (4) and (5) When the voltage is started to apply to the circuit or it is stopped applying, the irregular voltage may be generated for a transit period because of resonance or switching. Be sure to use the capacitors within rated voltage containing these 				
		Irregular voltage. Voltage (1) DC voltage (2) DC+AC voltage (3) AC voltage				
		Positional Measurement (Rated voltage) Vo-P 0				
		Voltage (4) Pulse voltage (A) (5) Pulse voltage (B)				
		Positional Measurement (Rated voltage)				
		Even below the rated voltage, if repetitive high frequency AC or pulse is applied, the reliability of the capacitors may be reduced.				
		The effective capacitance will vary depending on applied DC and AC voltages. The capacitors should be selected and designed in taking the voltages into consideration.				
		Abnormal voltage (surge voltage, static electricity, pulse voltage, etc.) shall not exceed the rated voltage.				
		5) When capacitors are used in a series connection, it is necessary to add a balancing circuit such as voltage dividing resistors in order to avoid an imbalance in the voltage applied to each capacitor.				
		2-4. Frequency When the capacitors (Class 2) are used in AC and/or pulse voltages, the capacitors may vibrate themselves and generate audible sound.				

No.	Process	Condition							
3	Designing P.C.board	The amount of solder at the terminations has a direct effect on the reliability of the capacitors. 1) The greater the amount of solder, the higher the stress on the chip capacitors, and the more likely that it will break. When designing a P.C.board, determine the shape and size of the solder lands to have proper amount of solder on the terminations.							
		Avoid using commo solder land for each		or multiple term	inations and pr	ovide individual			
		3) Size and recommer	nded land dime	nsions.					
			Chip o	capacitors Solo	ler land				
		Solder resist							
		Reflow soldering				(Unit : mm)			
		Case size Symbol	C1005 [CC0402]	C1608 [CC0603]	C2012 [CC0805]	C3216 [CC1206]			
		A	0.3 ~ 0.5	0.6 ~ 0.8	0.9 ~ 1.2	2.0 ~ 2.4			
		В	0.35 ~ 0.45	0.6 ~ 0.8	0.7 ~ 0.9	1.0 ~ 1.2			
		C	0.4 ~ 0.6	0.6 ~ 0.8	0.9 ~ 1.2	1.1 ~ 1.6			
		Case size Symbol	C3225 [CC1210]	C4532 [CC1812]	C5750 [CC2220]				
		A	2.0 ~ 2.4	3.1 ~ 3.7	4.1 ~ 4.8				
		B	1.0 ~ 1.2	1.2 ~ 1.4	1.2 ~ 1.4				
		C	1.9 ~ 2.5	2.4 ~ 3.2	4.0 ~ 5.0				
		Flow soldering (Un	recommend)		(Unit : m	nm)			
		Case size Symbol	C1608 [CC0603]	C2012 [CC0805]	C3216 [CC120				
		А	0.7 ~ 1.0	1.0 ~ 1.3	2.1 ~ 2.	5			
		В	0.8 ~ 1.0	1.0 ~ 1.2	1.1 ~ 1.	3			
		C	0.6 ~ 0.8	0.8 ~ 1.1	1.0 ~ 1.	3			

No.	Process		Condition	
3	Designing P.C.board	4) Recommende	d chip capacitors layout is as follo	owing.
			Disadvantage against bending stress	Advantage against bending stress
		Mounting face	Perforation or slit	Perforation or slit
			Break P.C.board with mounted side up.	Break P.C.board with mounted side down.
			Mount perpendicularly to perforation or slit	Mount in parallel with perforation or slit
		Chip arrangement (Direction)	Perforation or slit	Perforation or slit
			Closer to slit is higher stress	Away from slit is less stress
		Distance from slit	\mathcal{Q}_1 \mathcal{Q}_1 \mathcal{Q}_1 \mathcal{Q}_2	Q_2 \vdots \vdots $(Q_1 < Q_2)$

No. **Process** Condition 5) Mechanical stress varies according to location of chip capacitors on the P.C.board. 3 Designing P.C.board E Perforation 00000 00000 В Α Stress force A>B>ESlit A>D>EA > CWhen dividing printed wiring boards, the intensities of mechanical stress applied to capacitors are different according to each dividing method in the order of : Push-back < Slit < V-groove < Perforation. Therefore consider not only position of capacitors, but also the way of the dividing the printed wiring boards. 6) Layout recommendation Use of common Use of common Soldering with Example solder land with solder land chassis other SMD Lead wire Chassis Solder land Chip Excessive solder Solder Need to avoid Excessive solder PCB Adhesive Solder land Solder Missing solder Lead wire Solder resist Solder resist Recommendation Solder resist $Q_2 > Q_1$

No.	Process	Condition						
4	Mounting	4-1. Stress from mounting head If the mounting head is adjusted too low, it may induce excessive stress in the chip capacitors to result in cracking. Please take following precautions.						
		Adjust the bottor surface and not		ter of the mounting h	ead to reach on the P.C.board			
		2) Adjust the moun	ting head p	ressure to be 1 to 3N	I of static weight.			
		support from the	 To minimize the impact energy from mounting head, it is important to provide support from the bottom side of the P.C.board. See following examples. 					
			Not	recommended	Recommended			
		Single-sided mounting		Crack	Support pin is not to be underneath the capacitor.			
		Double-sides mounting	Solde	er Crack	Support pin			
		capacitors to caus	se crack. Ple ufficient pre	ease control the clos	echanical impact on the e up dimension of the centering and replacement of it.			
		4-2. Amount of aurie	<u>-</u>	a a a	<u> </u>			
		=		c c				
			C2012 [CC0805], C3	216 [CC1206]				
		_	a	0.2mm m	<u></u>			
		_	b	70 ~ 100կ	um			
			С	Do not touch the	solder land			

No.	Process	Condition				
5	Soldering	5-1. Flux selection Flux can seriously affect the performance of capacitors. Confirm the following to select the appropriate flux.				
		 It is recommended to use a mildly activated rosin flux (less than 0.1wt% chlorine). Strong flux is not recommended. 				
		2) Excessive flux must be avoided. Please provide proper amount of flux.				
		3) When water-soluble flux is used, enough washing is necessary.				
		5-2. Recommended soldering profile: Reflow method Refer to the following temperature profile at Reflow soldering.				
		Reflow soldering				
		Soldering Preheating → → Natural cooling → →				
		Reflow soldering is recommended for C1608,C2012,C3216 types, but only reflow soldering is allowed for other case sizes. 5-3. Recommended soldering peak temp and peak temp duration for Reflow soldering Pb free solder is recommended, but if Sn-37Pb must be used, refer to below.				
		Temp./Duration Reflow soldering				
		Solder Peak temp(°C) Duration(sec.)				
		Lead Free Solder 260 max. 10 max.				
		Sn-Pb Solder 230 max. 20 max.				
		Recommended solder compositions Lead Free Solder : Sn-3.0Ag-0.5Cu				

No.	Process			Condition		
5	Soldering	5-4. Soldering profile : Flow method (Unrecommend) Refer to the following temperature profile at Flow soldering.				
		Peak Temp (O)		ΔT	er 60 sec.	
		Reflow soldering	is rec	ommended for C160	8,C2012,C	3216 types.
		5-5. Recommended soldering peak temp and peak temp duration for Flow sol Pb free solder is recommended, but if Sn-37Pb must be used, refer to below				
		Temp./Durar	tion Flow soldering			
		Solder		Peak temp(°C)	Duration	n(sec.)
		Lead Free Solo	der	260 max.	5 m	ax.
		Sn-Pb Solder		250 max.	3 m	ax.
		Recommended solder c Lead Free Solder : Sn- 5-6. Avoiding thermal shock	3.0Ag			
		1) Preheating condition				
		Soldering	Case size		2000)	Temp. (°C)
		Reflow soldering	C1005(CC0402),C1608(CC0603), C2012(CC0805),C3216(CC1206) C3225(CC1210), C4532(CC1812),		206)	$\Delta T \le 150$ $\Delta T \le 130$
		Flow soldering		C5750(CC2220) C1608(CC0603),C2012(CC0805), C3216(CC1206)		$\Delta T \leq 150$ $\Delta T \leq 150$
		Cooling condition Natural cooling using ai cleaning, the temperatu				

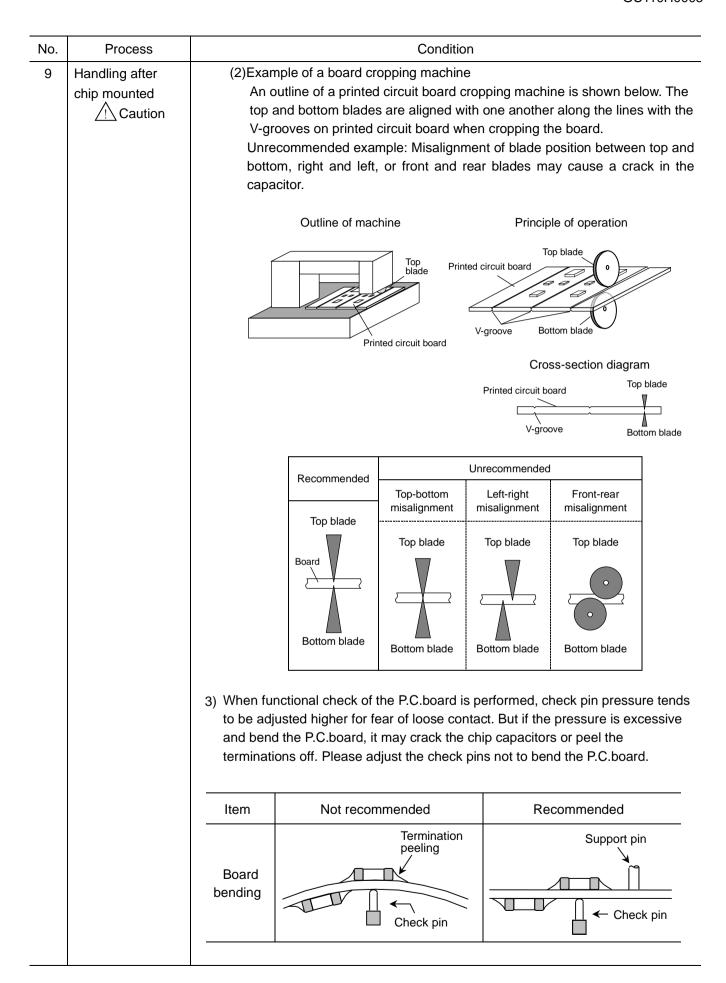
No.	Process	Condition
5	Soldering	5-7. Amount of solder Excessive solder will induce higher tensile force in chip capacitors when temperature changes and it may result in chip cracking. In sufficient solder may detach the capacitors from the P.C.board.
		Excessive solder Higher tensile force in chip capacitors to cause crack
	Sn-Zn solder af Please contact 5-9. Countermeas The misalignme patterns should the capacitors a reflow soldering (Refer to JEITA	Adequate Maximum amount Minimum amount
		 5-8. Sn-Zn solder Sn-Zn solder affects product reliability. Please contact TDK in advance when utilize Sn-Zn solder. 5-9. Countermeasure for tombstone The misalignment between the mounted positions of the capacitors and the land patterns should be minimized. The tombstone phenomenon may occur especially the capacitors are mounted (in longitudinal direction) in the same direction of the reflow soldering. (Refer to JEITA RCR-2335C Annex A (Informative), Recommendations to prevent the tombstone phenomenon.)

NI-	D	Condition				
No.	Process	Outliness III I I I I I I I I I I I I I I I I	Condition			
6	Solder repairing	(also called a "blower") ra				
		capacitor compared to understand capacitor uniformly with stress caused by quick Moreover, where ultra-scircuit board, reworking	heater may suppress the occurrence of cracks in the using a soldering iron. A spot heater can heat up a a small heat gradient which leads to lower thermal heating and cooling or localized heating. I mall capacitors are mounted close together on a printed with a spot heater can eliminate the risk of direct contact dering iron and a capacitor.			
		capacitor may occur due such an occurrence. Keep more than 5mm book The blower temperature. The airflow shall be set The diameter of the nozing standard and common Duration of blowing hot C2012(CC0805) and C3 C4532(CC1812) and C4 and melting temperature. The angle between the 45degrees in order to we	izle is recommended to be 2mm(one-outlet type). The size in. air is recommended to be 10s or less for C1608(CC0603), 3216(CC1206), and 30s or less for C3225(CC1210), 5750(CC2220), considering surface area of the capacitor e of solder. Inozzle and the capacitor is recommended to be ork easily and to avoid partial area heating. In ga soldering iron, preheating reduces thermal stress on			
		· Recommended rework	condition (Consult the component manufactures for details.)			
		Distance from nozzle	5mm and over			
		Nozzle angle	45degrees			
		Nozzle temp.	400°C and less			
		Airflow	Set as weak as possible (The airflow shall be the minimum value necessary for solder to melt in the conditions mentioned above.)			
		Nozzle diameter	ø2mm (one-outlet type)			
		Blowing duration	10s and less (C1608[CC0603], C2012[CC0805], C3216[CC1206]) 30s and less (C3225[CC1210], C4532[CC1812], C5750[CC2220])			
		• Example of recomme	nded spot heater use One-outlet type nozzle			
			Angle : 45degrees			
		Excess solder causes m in cracks. Insufficient so substrate and may result of the printed wiring boa	d be suitable to from a proper fillet shape. sechanical and thermal stress on a capacitor and results older causes weak adherence of the capacitor to the lt in detachment of a capacitor and deteriorate reliability and. stropriate solder fillet shape for 5-7. Amount of solder.			

No.	Process	Condition					
6	Solder repairing	6-2. Solder repair by s	solder iron				
		1) Selection of the soldering iron tip Tip temperature of solder iron varies by its type, P.C.board material and solder land size. The higher the tip temperature, the quicker the operation. However, heat shock may cause a crack in the chip capacitors. Please make sure the tip temp. before soldering and keep the peak temp and time in accordance with following recommended condition.					
				nual soldering			
		(Solder iron) Peak Temp O O O Preheating 3sec. (As short as possible)					
		Recommended	solder iron co	ondition (Sn-Pb So	lder and Lea	ad Free Solder)	
		Case size	Temp. (°C)	Duration (sec.)	Wattage (V	V) Shape (mm)	
		C1005(CC0402) C1608(CC0603) C2012(CC0805) C3216(CC1206)	C1608(CC0603) C2012(CC0805) 350 max.				
		C3225(CC1210) C4532(CC1812) C5750(CC2220)	280 max.				
		 * Please preheat the chip capacitors with the condition in 6-3 to avoid the thermal shock. 2) Direct contact of the soldering iron with ceramic dielectric of chip capacitors may cause crack. Do not touch the ceramic dielectric and the terminations by solder iron. 					
		3) It is not recommended to reuse dismounted capacitors.					
		6-3. Avoiding thermal shock					
		Preheating condit	ion				
		Soldering	1	Case size		Temp. (°C)	
		Manual solde	C2012	(CC0402),C1608(CC (CC0805),C3216(CC	C1206)	ΔT ≦ 150	
			C3225	(CC1210), C4532(C (CC2220)	C1812),	$\Delta T \leq 130$	

No.	Process	Condition
7	Cleaning	If an unsuitable cleaning fluid is used, flux residue or some foreign articles may stick to chip capacitors surface to deteriorate especially the insulation resistance.
		2) If cleaning condition is not suitable, it may damage the chip capacitors.
		2)-1. Insufficient washing
		(1) Terminal electrodes may corrode by Halogen in the flux.
	(2) Halogen in the flux may adhere on the surface of capacitors, and lower the insulation resistance.	
		(3) Water soluble flux has higher tendency to have above mentioned problems (1) and (2).
		2)-2. Excessive washing
		When ultrasonic cleaning is used, excessively high ultrasonic energy output can affect the connection between the ceramic chip capacitor's body and the terminal electrode. To avoid this, following is the recommended condition.
		Power : 20 W/l max.
		Frequency: 40 kHz max.
		Washing time: 5 minutes max. 2)-3. If the cleaning fluid is contaminated, density of Halogen increases, and it may bring the same result as insufficient cleaning.
8	Coating and	1) When the P.C.board is coated, please verify the quality influence on the product.
	molding of the P.C.board	Please verify carefully that there is no harmful decomposing or reaction gas emission during curing which may damage the chip capacitors.
		3) Please verify the curing temperature.

No.	Process		Condition				
9	Handling after chip mounted	, ,	ention not to bend or distort the P.C.board after soldering in wise the chip capacitors may crack.				
	<u> </u>	,	cropping should not be carried	Twist			
		cropping jig as shown prevent inducing mec (1)Example of a boa Recommended ex close to the croppi the capacitor is co Unrecommended of the pushing directi	n in the following figure or a hanical stress on the board. rd cropping jig cample: The board should being jig so that the board is not mpressive. example: If the pushing point	Id be carried out using a board a board cropping apparatus to be pushed from the back side, bent and the stress applied to is far from the cropping jig and be board, large tensile stress is ks.			
		Outline of jig	Recommended	Unrecommended			
		Printed circuit board V-groove Board Slot Cropping jig	Printed circuit board Components Load point V-groove Slot	Load point Printed circuit board V-groove Slot			



No.	Process	Condition
10	Handling of loose chip capacitors	If dropped the chip capacitors may crack. Once dropped do not use it. Especially, the large case sized chip capacitors are tendency to have cracks easily, so please handle with care. Crack Floor
		Piling the P.C.board after mounting for storage or handling, the corner of the P.C. board may hit the chip capacitors of another board to cause crack. Crack P.C.board Crack
11	Capacitance aging	The capacitors (Class 2) have aging in the capacitance. They may not be used in precision time constant circuit. In case of the time constant circuit, the evaluation should be done well.
12	Estimated life and estimated failure rate of capacitors	As per the estimated life and the estimated failure rate depend on the temperature and the voltage. This can be calculated by the equation described in JEITA RCR-2335C Annex F (Informative) Calculation of the estimated lifetime and the estimated failure rate (Voltage acceleration coefficient: 3 multiplication rule, Temperature acceleration coefficient: 10°C rule) The failure rate can be decreased by reducing the temperature and the voltage but they will not be guaranteed.

No.	Process	Condition
13	Caution during operation of equipment	A capacitor shall not be touched directly with bare hands during operation in order to avoid electric shock. Electric energy held by the capacitor may be discharged through the human body when touched with a bare hand. Even when the equipment is off, a capacitor may stay charged. The capacitor should be handled after being completely discharged using a resistor.
		2) The terminals of a capacitor shall not be short-circuited by any accidental contact with a conductive object. A capacitor shall not be exposed to a conductive liquid such as an acid or alkali solution. A conductive object or liquid, such as acid and alkali, between the terminals may lead to the breakdown of a capacitor due to short circuit.
		 Confirm that the environment to which the equipment will be exposed during transportation and operation meets the specified conditions. Do not to use the equipment in the following environments. Environment where a capacitor is spattered with water or oil Environment where a capacitor is exposed to direct sunlight Environment where a capacitor is exposed to Ozone, ultraviolet rays or radiation Environment where a capacitor exposed to corrosive gas(e.g. hydrogen sulfide, sulfur dioxide, chlorine. ammonia gas etc.) Environment where a capacitor exposed to vibration or mechanical shock exceeding the specified limits. Atmosphere change with causes condensation
14	Others Caution	The products listed on this specification sheet are intended for use in general electronic equipment (AV equipment, telecommunications equipment, home appliances, amusement equipment, computer equipment, personal equipment, office equipment, measurement equipment, industrial robots) under a normal operation and use condition. The products are not designed or warranted to meet the requirements of the applications listed below, whose performance and/or quality require a more stringent level of safety or reliability, or whose failure, malfunction or trouble could cause serious damage to society, person or property. Please understand that we are not responsible for any damage or liability caused by use of the products in any of the applications below or for any other use exceeding the range or conditions set forth in this specification sheet. If you intend to use the products in the applications listed below or if you have special requirements exceeding the range or conditions set forth in this specification, please contact us.
		 (1) Aerospace/Aviation equipment (2) Transportation equipment (cars, electric trains, ships, etc.) (3) Medical equipment (Excepting Pharmaceutical Affairs Law classification Class1, 2) (4) Power-generation control equipment (5) Atomic energy-related equipment (6) Seabed equipment (7) Transportation control equipment (8) Public information-processing equipment (9) Military equipment (10) Electric heating apparatus, burning equipment (11) Disaster prevention/crime prevention equipment (12) Safety equipment (13) Other applications that are not considered general-purpose applications When designing your equipment even for general-purpose applications, you are kindly requested to take into consideration securing protection circuit/device or providing backup circuits in your equipment.

13. TAPE PACKAGING SPECIFICATION

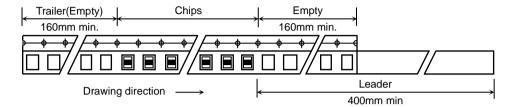
1. CONSTRUCTION AND DIMENSION OF TAPING

1-1. Dimensions of carrier tape

Dimensions of paper tape shall be according to Appendix 3, 4.

Dimensions of plastic tape shall be according to Appendix 5, 6.

1-2. Bulk part and leader of taping

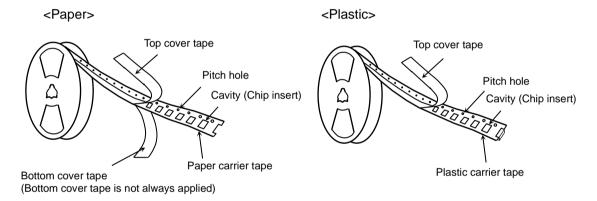


1-3. Dimensions of reel

Dimensions of Ø178 reel shall be according to Appendix 7, 8.

Dimensions of Ø330 reel shall be according to Appendix 9, 10.

1-4. Structure of taping

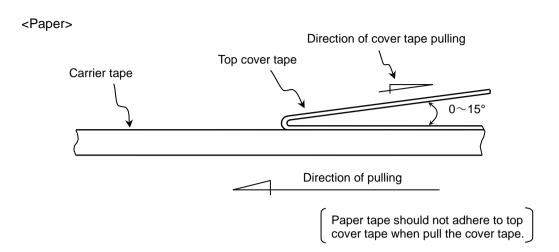


2. CHIP QUANTITY

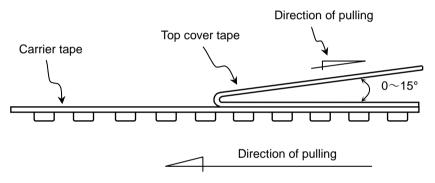
Please refer to detail page on TDK web.

3. PERFORMANCE SPECIFICATIONS

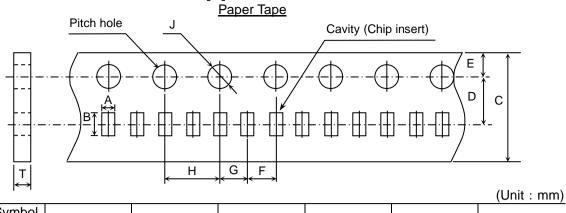
3-1. Fixing peeling strength (top tape)0.05N < Peeling strength < 0.7N



<Plastic>



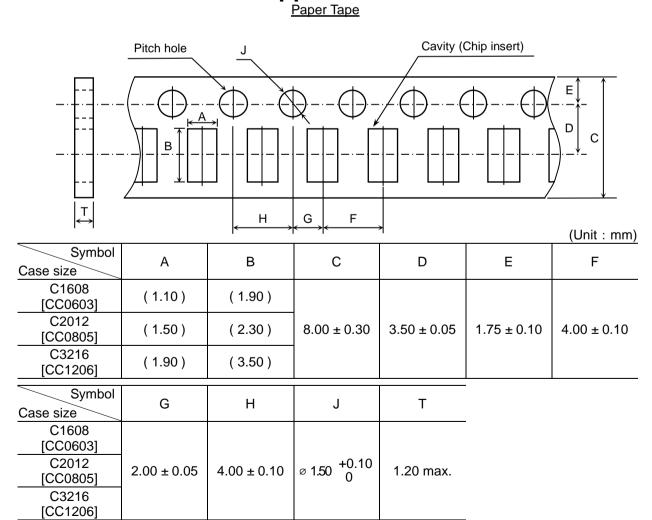
- 3-2. Carrier tape shall be flexible enough to be wound around a minimum radius of 30mm with components in tape.
- 3-3. The missing of components shall be less than 0.1%
- 3-4. Components shall not stick to fixing tape.
- 3-5. When removing the cover tape, there shall not be difficulties by unfitting clearance gap, burrs and crushes of cavities. Also the sprocket holes shall not be covered by absorbing dust into the suction nozzle.



						(Unit: min)
Symbol Case size	А	В	С	D	E	F
C1005 [CC0402]	(0.65)	(1.15)	8.00 ± 0.30	3.50 ± 0.05	1.75 ± 0.10	2.00 ± 0.05
Symbol Case size	G	Н	J	Т	-	
C1005 [CC0402]	2.00 ± 0.05	4.00 ± 0.10	ø 1.50 ^{+0.10}	0.60±0.05	-	

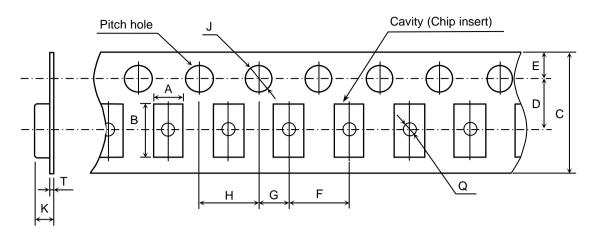
) Reference value.

Appendix 4



() Reference value.

Plastic Tape



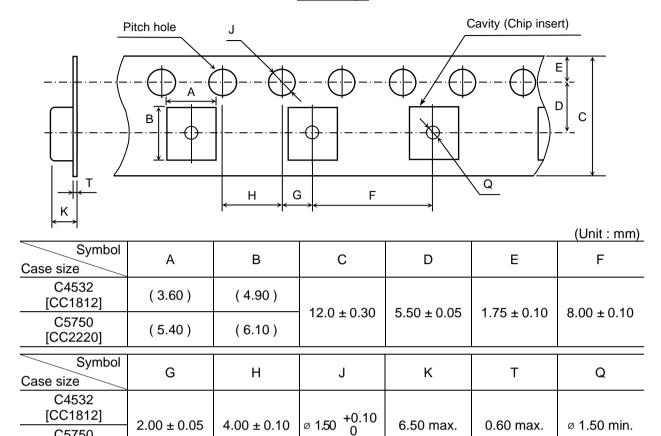
						(Unit : mm)
Symbol Case size	А	В	С	D	E	F
C2012 [CC0805]	(1.50)	(2.30)	8.00 ± 0.30	3.50 ± 0.05		
C3216 [CC1206]	(1.90)	(3.50)	*12.0 ± 0.30	*5.50 ± 0.05	1.75 ± 0.10	4.00 ± 0.10
C3225 [CC1210]	(2.90)	(3.60)	12.0 ± 0.00	0.00 ± 0.00		
Symbol Case size	G	Н	J	К	Т	Q
C2012 [CC0805]				2.50 max.		
C3216 [CC1206]	2.00 ± 0.05	4.00 ± 0.10	ø 1.50 ^{+0.10}	2.50 IIIax.	0.60 max.	ø 0.50 min.
C3225 [CC1210]				3.40 max.		

() Reference value.

* Applied to thickness, 2.5mm products.

Exceptionally no hole in the cavity is applied. Please inquire if hole in cavity is mandatory.

Plastic Tape

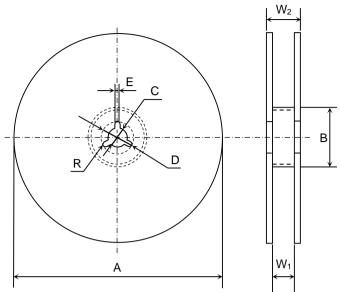


⁾ Reference value.

C5750 [CC2220]

Exceptionally no hole in the cavity is applied. Please inquire if hole in cavity is mandatory.

<u>Dimensions of reel</u> (Material : Polystyrene) C1005, C1608, C2012, C3216, C3225

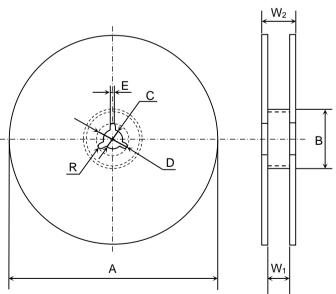


				•		(Offic . Hilli)
Symbol	Α	В	С	D	Е	W ₁
Dimension	Ø 178 ± 2.0	Ø 60 ± 2.0	∅ 13 ± 0.5	Ø 21 ± 0.8	2.0 ± 0.5	9.0 ± 0.3

Symbol	W_2	R	
Dimension	13.0 ± 1.4	1.0	

Appendix 8

<u>Dimensions of reel</u> (Material : Polystyrene) C3225(2.5mm thickness products), C4532, C5750

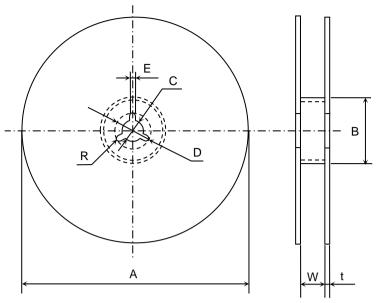


 Symbol
 A
 B
 C
 D
 E
 W₁

 Dimension
 Ø 178 ± 2.0
 Ø 60 ± 2.0
 Ø 13 ± 0.5
 Ø 21 ± 0.8
 2.0 ± 0.5
 13.0 ± 0.3

Symbol	W ₂	R	
Dimension	17.0 ± 1.4	1.0	

<u>Dimensions of reel</u> (Material : Polystyrene) C1005, C1608, C2012, C3216, C3225

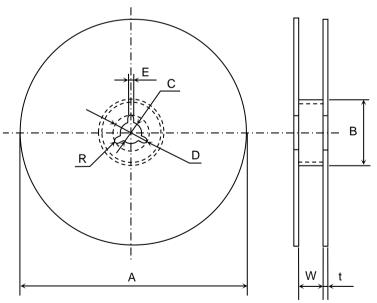


	ı			ı		(Unit: mm)
Symbol	А	В	С	D	Е	W
Dimension	ø 382 max. (Nominal ø 330)	ø 50 min.	∅ 13 ± 0.5	∅ 21 ± 0.8	2.0 ± 0.5	10.0 ± 1.5

Symbol	t	R	
Dimension	2.0 ± 0.5	1.0	

Appendix 10

<u>Dimensions of reel</u> (Material : Polystyrene) C3225(2.5mm thickness products), C4532, C5750



 Symbol
 A
 B
 C
 D
 E
 W

 Dimension

 ^Ø 382 max. (Nominal Ø 330)

 Ø 50 min.
 Ø 13 ± 0.5
 Ø 21 ± 0.8
 2.0 ± 0.5
 14.0 ± 1.5

Symbol	t	R
Dimension	2.0 ± 0.5	1.0